

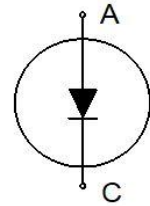
EDT3 Diode for Automotive Applications

Diode

Quality Requirement Category: Automotive

Features

- 750V Emitter Controlled Diode technology
- Soft, fast switching
- Low reverse recovery charge
- Improved commutation behavior for reduced IGBT turn-on losses
- Small temperature coefficient
- 185°C maximum junction temperature



Applications

- Drives

Description

- Recommended for power modules

Product Validation

- Technology qualified for Automotive Applications. Product validation according to AEC-Q101.

Key Performance Parameters

| Chip Type | V_{RRM} | I_{Fn} | Die Size | Package |
|-------------|-----------|----------|--------------------|--------------|
| IDC62D75H8A | 750V | 400A | 62 mm ² | Sawn on foil |

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1 Parameters and Characteristics

Table 1 Mechanical Parameters

| | | |
|-------------------------------------|---|---|
| Raster size | 10 x 6.2 | mm ² |
| Area total | 62 | mm ² |
| Anode pad size | See chip drawing | |
| Silicon thickness | 68 | μm |
| Wafer size | 200 | mm |
| Maximum possible chips per wafer | 424 | |
| Passivation frontside | Photoimide | |
| Pad metal | AlSiCu | |
| Backside metal | Ni Ag system | |
| Die bond ¹ | Soft solder | |
| Frontside interconnect ¹ | Wire bond: Al, ≤ 500 μm | |
| Reject ink dot size | Inkless | |
| Storage environment (<6 months) | For original and sealed MBB bags ² | Ambient atmosphere air, temperature 17°C – 25°C |

Table 2 Maximum Ratings³

| Parameter | Symbol | Conditions | Value | Unit |
|--|---------------|--|--------------|------|
| Maximum reverse voltage | V_{RRM} | $25^{\circ}\text{C} \leq T_{vj} \leq 185^{\circ}\text{C}$ | 750 | V |
| | | $T_{vj} = -40^{\circ}\text{C}^4$ | 710 | |
| Continuous forward current, limited by $T_{vj\ max}$ | I_F | | _5 | A |
| Pulsed forward current, t_p limited by $T_{vj\ max}$ | $I_{F,pulse}$ | | 1200 | A |
| Virtual junction temperature | T_{vj} | | -40 ... +185 | °C |
| Safe operating area | SOA | $I_{F,max} = 800\ \text{A}, V_{R,max} = V_{RRM}, -40^{\circ}\text{C} \leq T_{vj} \leq 185^{\circ}\text{C}$ | | |

¹ Depending on customer specific assembly process

² https://www.infineon.com/dgdl/Storage_of_Products_Supplied_by_Infineon_Technologie.pdf?fileId=5546d461641369bf01643b95d8500011

³ Not subject to production test - verified by design/characterization.

⁴ V_{RRM} increases linearly between -40°C and 25°C.

⁵ Depending on thermal properties of assembly.

Table 3 Static Characteristics (Tested on Wafer), $T_{vj}=25^{\circ}\text{C}$

| Parameter | Symbol | Conditions | Value | | | Unit |
|-------------------------|--------|---------------------|-------|------|------|---------------|
| | | | min. | typ. | max. | |
| Forward voltage drop | V_F | $I_F = 80\text{A}$ | - | 1.35 | 1.5 | V |
| Reverse leakage current | I_R | $V_R = 750\text{V}$ | - | - | 100 | μA |

Table 4 Electrical Characteristics¹

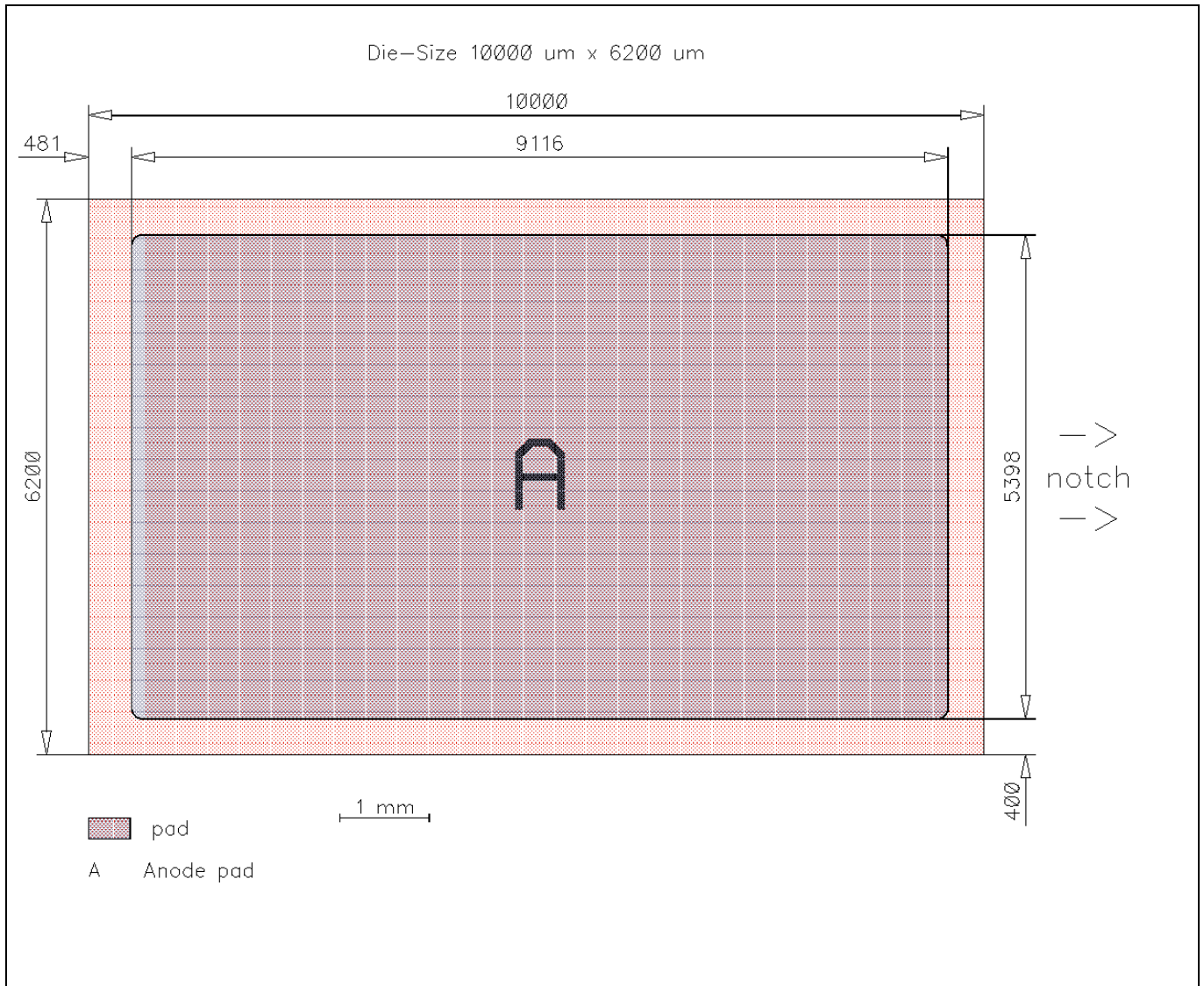
| Parameter | Symbol | Conditions | Value | | | Unit | |
|----------------------|--------|---------------------|--------------------------------|------|------|------|---|
| | | | min. | typ. | max. | | |
| Forward voltage drop | V_F | $I_F = 400\text{A}$ | $T_{vj} = 25^{\circ}\text{C}$ | - | 2.00 | 2.3 | V |
| | | | $T_{vj} = 185^{\circ}\text{C}$ | - | 1.70 | - | |

2 Further Electrical Characteristics

Note: Switching characteristics and thermal properties are dependent on module design and mounting technology and can therefore not be specified for a bare die.

¹ Not subject to production test - verified by design/characterization.

3 Chip Drawing



4 Bare Die Product Specifics

Note: Test coverage at wafer level for diodes cannot cover the full range of customer application conditions. Therefore it is the responsibility of the customer to test all performance characteristics, which are relevant for their specific application, at the package level, including SOA.

Description

- AQL 0.1 for visual inspection according to failure catalogue

Revision History

| Document version | Date of release | Description of changes |
|-------------------------|------------------------|-------------------------------|
| V1.00 | 2025-September-10 | Initial datasheet |
| | | |
| | | |
| | | |

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